



SPECIFICATION

(Reference sheet)

· Supplier : Samsung electro-mechanics · Samsung P/N : CL05X105MR3LNNC

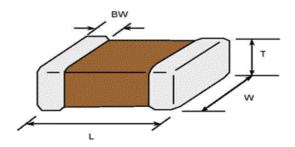
Product : Multi-layer Ceramic Capacitor Description : CAP, 1uF, 4V, ±20%, X6S, 0402

A. Samsung Part Number

<u>CL</u> <u>05</u> <u>X</u> <u>105</u> <u>M</u> <u>R</u> <u>3</u> <u>L</u> <u>N</u> <u>N</u> <u>C</u> 1 2 3 4 5 6 7 8 9 10 11

1	Series	Samsung Multi-layer Ceramic Capacitor				
2	Size	0402 (inch code)	$L: 1.00 \pm 0.05 \text{ mm}$	W :	$0.50 \pm 0.05 \; \mathrm{mm}$	
			Thickness divisio	n	Low profile	
3	Dielectric	X6S	Inner electrode		Ni	
4	Capacitance	1 uF	Termination		Cu	
⑤	Capacitance	±20 %	Plating		Sn 100%	(Pb Free)
	tolerance		Product		Normal	
6	Rated Voltage	4 V	10 Special		Reserved for fu	uture use
7	Thickness	$0.30 \pm 0.03 \text{ mm}$	① Packaging		Cardboard Typ	e, 7" reel

B. Structure & Dimension



Samouna D/N	Dimension(mm)				
Samsung P/N	L	W	Т	BW	
CL05X105MR3LNNC	1.00 ± 0.05	0.50 ± 0.05	0.30 ± 0.03	0.25 ± 0.10	

C. Samsung Reliablility Test and Judgement Condition

	Judgement	Test condition		
Capacitance	Within specified tolerance	1 ^{kHz} ±10% / 1.0±0.2Vrms		
Tan δ (DF)	0.1 max.	*A capacitor prior to measuring the capacitance is heat treated at $150^{\circ}\text{C}+0/-10^{\circ}\text{C}$ for 1hour and maintained in ambient air for 24±2 hours.		
Insulation	10,000Mohm or 100Mohm×μF	Rated Voltage 60~120 sec.		
Resistance	Whichever is smaller			
Appearance	No abnormal exterior appearance	Microscope (×10)		
Withstanding	No dielectric breakdown or	250% of the rated voltage		
Voltage	mechanical breakdown			
Temperature	X6S			
Characteristics	(From-55℃ to 105℃, Capacitance change	should be within ±22%)		
Adhesive Strength	No peeling shall be occur on the	500g·f, for 10±1 sec.		
of Termination	terminal electrode			
Bending Strength	Capacitance change : within ±12.5%	Bending to the limit (1mm) with 1.0mm/sec.		
Solderability	More than 75% of terminal surface is to be soldered newly	SnAg3.0Cu0.5 solder 245±5°C, 3±0.3sec. (preheating : 80~120°C for 10~30sec.)		
Resistance to	Capacitance change : within ±7.5%	Solder pot : 270±5°C, 10±1sec.		
Soldering Heat	Tan δ, IR : initial spec.			
Vibration Test	Capacitance change : within ± 10% Tan δ, IR : initial spec.	Amplitude: 1.5mm From 10Hz to 55Hz (return: 1min.) 2hours × 3 direction (x, y, z)		
Moisture Resistance	Capacitance change: within ±12.5% Tan δ: 0.125 max IR: 500Mohm or 12.5Mohm × μ Whichever is smaller	With rated voltage 40±2°C, 90~95%RH, 500+12/-0hrs		
High Temperature Resistance	Capacitance change : within ±12.5% Tan δ : 0.125 max IR : 1,000Mohm or 25Mohm × μ Whichever is smaller	With 150% of the rated voltage Max. operating temperature 1,000+48/-0hrs		
Temperature Cycling	Capacitance change : within ±15% Tan δ, IR : initial spec.	1 cycle condition Min. operating temperature → 25°C → Max. operating temperature → 25°C 5 cycle test		

X The reliability test condition can be replaced by the corresponding accelerated test condition.

D. Recommended Soldering method:

Reflow (Reflow Peak Temperature : 260±5°C, 30sec.)



Product specifications included in the specifications are effective as of March 1, 2013.

Please be advised that they are standard product specifications for reference only.

We may change, modify or discontinue the product specifications without notice at any time.

So, you need to approve the product specifications before placing an order.

Should you have any question regarding the product specifications,

please contact our sales personnel or application engineers.